

22nd IEEE European Test Symposium 2017 – Program at a Glance

Day	MONDAY - May 22				TUESDAY - May 23				WEDNESDAY - May 24				THURSDAY - May 25			FRIDAY - May 26																									
Room	Atheneum 1-3	Ares			Demetra	Ares	Atheneum 1-3	Atheneum 4	Demetra	Ares	Atheneum 1-3	Atheneum 4	Demetra	Ares	Atheneum 1-3	Ares	Atheneum 1-3																								
08:00-08:30	Registration @Foyer				Registration @Foyer				Registration @Foyer				Registration @Foyer			Workshop Registration @Foyer																									
08:30-09:00					Conference Opening @Demetra				Plenary Keynote 2: Hans-Juergen Wagner, Advantest Europe GmbH @Demetra				Plenary Keynote 3: Krisztián Flautner, ARM, USA @Demetra			RESCUE Workshop	TESTA Workshop																								
09:00-09:30					Plenary Keynote 1: Mohamad Sawan, Polytechnique Montreal, Canada @Demetra				Coffee Break + Poster Session 2 + Table-Top Demos @Atheneum Terrace & Foyer				Coffee Break + Poster Session 3 + Table-Top Demos @Atheneum Terrace & Foyer			Coffee Break @Atheneum Terrace																									
09:30-10:00					Coffee Break + Poster Session 1 + Table-Top Demos @Atheneum Terrace & Foyer																																				
10:00-10:30	Regular Session 1: AMS, RF & MEMS I				ETS ² 1: Launching automotive chips with high quality and yield				Vendor Session 1				Regular Session 3: Digital Test			Regular Session 4: Memories I			Embedded Tutorial 1: Counteracting Malicious Faults in Crypto Circuits			McCluskey PhD Thesis Award																			
10:30-11:00																									Regular Session 5: Diagnosis			Regular Session 6: Memories II			Embedded Tutorial 2: Security and Trust for AMS/RF Domain			Regular Session 8: Security			Special Session 2: Testing for Automotive			Special Session 3: Big Data for Test Engineering	
11:00-11:30	Registration @Foyer				Lunch Break @Kalypso Restaurant				Lunch Break @Kalypso Restaurant				Lunch Break @Kalypso Restaurant			Lunch Break @Kalypso Restaurant																									
11:30-12:00																		Special Session 1: Adaptive, Self-Learning, Cognitive Systems				ETS ² 2: Quality and Reliability at reasonable (test) costs				Vendor Session 2				Regular Session 7: AMS, RF & MEMS II			Embedded Tutorial 3: Volume Diagnosis Data Mining			Embedded Tutorial 4: Testing IO interfaces in 2.5D and 3D Systems			Industry Wish List @Demetra		
12:00-12:30																																									
12:30-13:00																		ETS SC Meeting @Hera				ETS SC Meeting @Hera				ETS SC Meeting @Hera				ETS18 ExecCom Meeting @Hera			RESCUE Project Management Meeting								
13:00-13:30	TSS@ETS Tutorial 1: Machine Learning for System Level Test and Diagnosis				TSS@ETS Tutorial 2: Self-Awareness and Resilience Against Faults, Bugs and Attacks				Coffee Break @Atheneum Terrace				Break			Colloquium in Honor of Joan Figueras			TESTA & RESCUE Workshops Joint Panel @Ares																						
13:30-14:00																					Regular Session 2: Fault Tolerance and Approximate Computing				ETS ² 3: AMS vs. high quality requirements				Vendor Session 3				Break								
14:00-14:30	Coffee Break @Atheneum Terrace				Wine & Cheese Panel 1: What are the most significant defects not modeled or targeted adequately?				Wine & Cheese Panel 2: In-field self-test for automotive ICs: which solutions?				Social Event (15:30 - 22:30)			TESTA & RESCUE Workshops Joint Panel @Ares			Workshops' Joint Welcome Reception @Blue Breeze Lounge																						
14:30-15:00																					Welcome Reception @Blue Breeze Lounge																				
15:00-15:30	TSS@ETS Tutorial 1: Machine Learning for System Level Test and Diagnosis				TSS@ETS Tutorial 2: Self-Awareness and Resilience Against Faults, Bugs and Attacks				Break				Colloquium in Honor of Joan Figueras			TESTA & RESCUE Workshops Joint Panel @Ares																									
15:30-16:00																		Break																							
16:00-16:30	Coffee Break @Atheneum Terrace				Wine & Cheese Panel 1: What are the most significant defects not modeled or targeted adequately?				Wine & Cheese Panel 2: In-field self-test for automotive ICs: which solutions?				Social Event (15:30 - 22:30)			Colloquium in Honor of Joan Figueras			TESTA & RESCUE Workshops Joint Panel @Ares																						
16:30-17:00																					Welcome Reception @Blue Breeze Lounge																				
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17:30-18:00																		Break																							
18:00-18:30	Break				Wine & Cheese Panel 1: What are the most significant defects not modeled or targeted adequately?				Wine & Cheese Panel 2: In-field self-test for automotive ICs: which solutions?				Social Event (15:30 - 22:30)			Colloquium in Honor of Joan Figueras			TESTA & RESCUE Workshops Joint Panel @Ares																						
18:30-19:00																					Welcome Reception @Blue Breeze Lounge																				
19:00-19:30	Welcome Reception @Blue Breeze Lounge				Wine & Cheese Panel 1: What are the most significant defects not modeled or targeted adequately?				Wine & Cheese Panel 2: In-field self-test for automotive ICs: which solutions?				Social Event (15:30 - 22:30)			Colloquium in Honor of Joan Figueras			TESTA & RESCUE Workshops Joint Panel @Ares																						
19:30-20:00																					Welcome Reception @Blue Breeze Lounge																				
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21:00-21:30	Welcome Reception @Blue Breeze Lounge				Wine & Cheese Panel 1: What are the most significant defects not modeled or targeted adequately?				Wine & Cheese Panel 2: In-field self-test for automotive ICs: which solutions?				Social Event (15:30 - 22:30)			Colloquium in Honor of Joan Figueras			TESTA & RESCUE Workshops Joint Panel @Ares																						
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